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APPLICATION NOTE 4157

Enhanced RSSI Calibration for APDs Using the DS1864

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Abstract: This application note explains how to use the DS1864 SFP laser and diagnostic IC to perform enhanced receive signal strength indicator (RSSI) calibration for optical receivers that use an avalanche photodiode (APD). The article discusses the relationship between APD and RSSI, and describes the principal operation of enhanced RSSI on the DS1864.

APD RSSI Overview

Many optical modules use avalanche photodiode-based (APD) optical receivers for high-sensitivity applications. In such modules, receive signal strength indicator (RSSI) is based on the optical photocurrent, rather than electrical signal amplitude at the output of the transimpedance amplifier (TIA). **Figure 1** shows a typical current-monitor circuit with a voltage output.

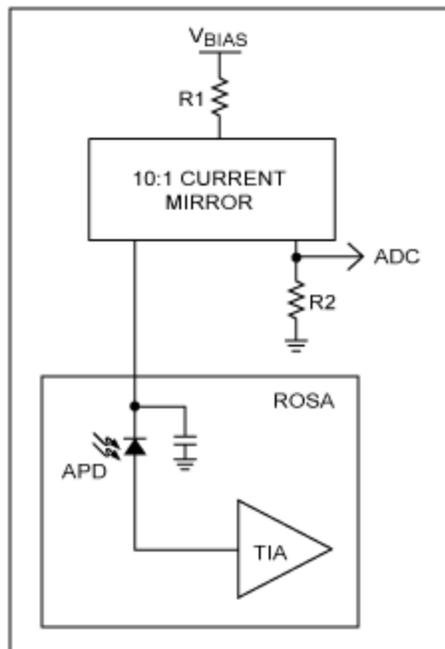


Figure 1. Schematic for a typical APD current monitor.

The current through the APD is given by the equation $I_{APD} = P_{RX} \times M \times \eta$ where:

I_{APD} is current in mA

P_{RX} is received power in mW

M is the APD avalanche gain factor

η is the conversion efficiency in A/W

Conversion efficiency depends on many structural factors, temperature, and wavelength; it is typically between $0.65 < \eta < 0.95$.

APD gain is achieved by biasing the APD near its breakdown voltage, V_{BR} , which is typically between 20V and 80V and dependent on both the APD structure and operating temperature. The closer the APD is biased to its specific breakdown voltage, the higher is M. While the APD is in avalanche mode, the M is proportional to V_{BR} and V_{AP} , the voltage applied to the APD, as shown in the relationship of $M = \sqrt{V_{BR}/(V_{BR} - V_{APD})}$. The exact calculation for M depends on APD material type, gain region size, and other variables. For a typical APD operating between 155Mbps and 40Gbps, M is typically set at between $3 < M < 10$. A typical APD gain curve is given in **Figure 2**. Referring back to Figure 1, R1 is used to increase the dynamic range of the APD by decreasing M as optical input power increases. As the current through R1 increases, the voltage on the APD decreases. This moves the APD further from its breakdown voltage, thereby decreasing M, as shown by $M = \sqrt{V_{BR}/(V_{BR} - (V_{BIAS} - I_{APD} \times R1))}$. Note that M is dependent on itself, as shown by the substitution into the previous equation $M = \sqrt{V_{BR}/(V_{BR} - (V_{BIAS} - P_{RX} \times M \times \eta \times R1))}$. Using a current mirror with a 10:1 monitor ratio, the voltage presented to the ADC (V_{ADC}) is given by the equation:

$$V_{ADV} = I_{APD} \times (1/10) \times R2 = P_{RX} \times M \times \eta \times (1/10) \times R2$$

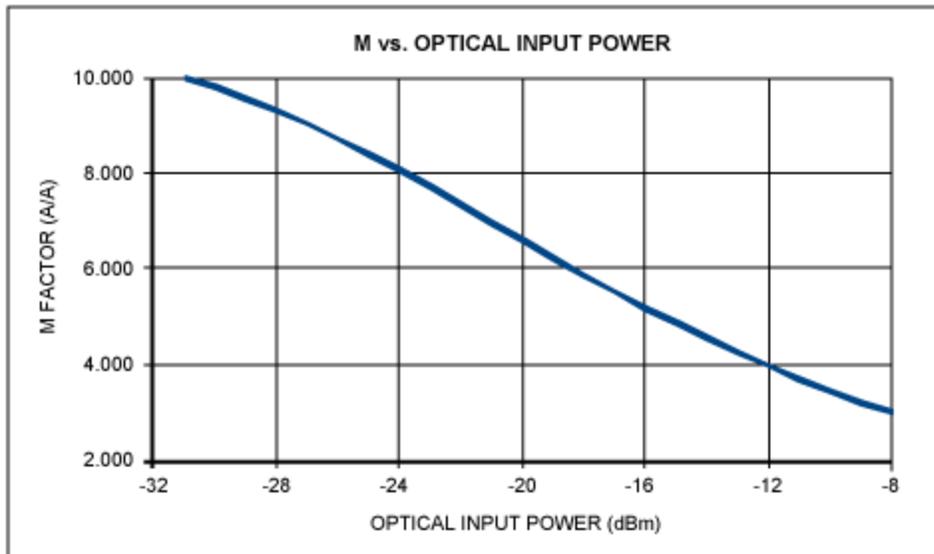


Figure 2. A typical APD gain curve.

Enhanced RSSI Overview

The **DS1864** SFP laser and diagnostic IC includes an enhanced RSSI mode for the MON3 channel, which is a differential input to the 13-bit ADC. Enhanced RSSI is also known as dual-range functionality. In enhanced RSSI mode, the ADC takes up to two different readings, called fine and course modes. (Pages 20 and 21 of the DS1864 data sheet describe this mode.) The fine reading is automatically used

to measure small input signals. If a large signal is input to the ADC, however, the course mode is automatically used.

For APD RSSI measurements, it is important to note that the two ranges of enhanced RSSI have independent offset and scale calibration factors. Further, the fine mode also allows for up to 7 right shifts of the ADC result. When configured for 7 right shifts, the maximum fine mode reading is 01FFh, and the minimum course mode reading is 01E0h. There are 31 bits of hysteresis to prevent the two ranges from toggling in the overlapping region (01FFh to 01E0h).

Dual-Range Calibration for APD RSSI

To comply with SFF-8472, the monitor circuit and ADC must be calibrated so that one LSB = 0.1µW. Because M varies with input power, the optimal ADC step size must vary to maintain each LSB at 0.1µW. If M varies from 3 to 10 and a single ADC LSB weight is used, this will yield a total error of $10 \times \log_{10}(10/3) = 5.23\text{dB}$. Because the DS1864 allows independent calibration of two different ADC ranges, two different LSB weights can be defined. This reduces the error caused by a change in M. **Figure 3** shows the ideal LSB weight and two different weights based on a typical APD and monitor.

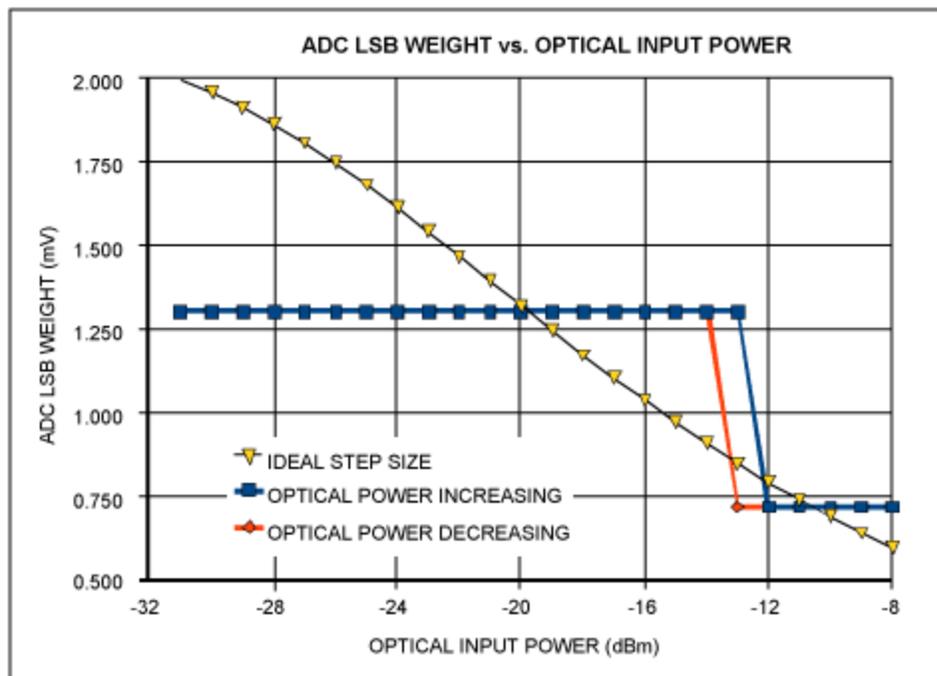


Figure 3. A typical APD monitor's the ideal ADC LSB weight and actual calibrated weights.

The crossover between the LSB weights occurs between ADC step 1E0h and 1FFh when the MON3 fine conversion is configured for 7 right shifts. The optimum LSB weight values must be determined based on the APD and monitor circuit. The resulting RSSI error given this previous example is shown in **Figure 4**.

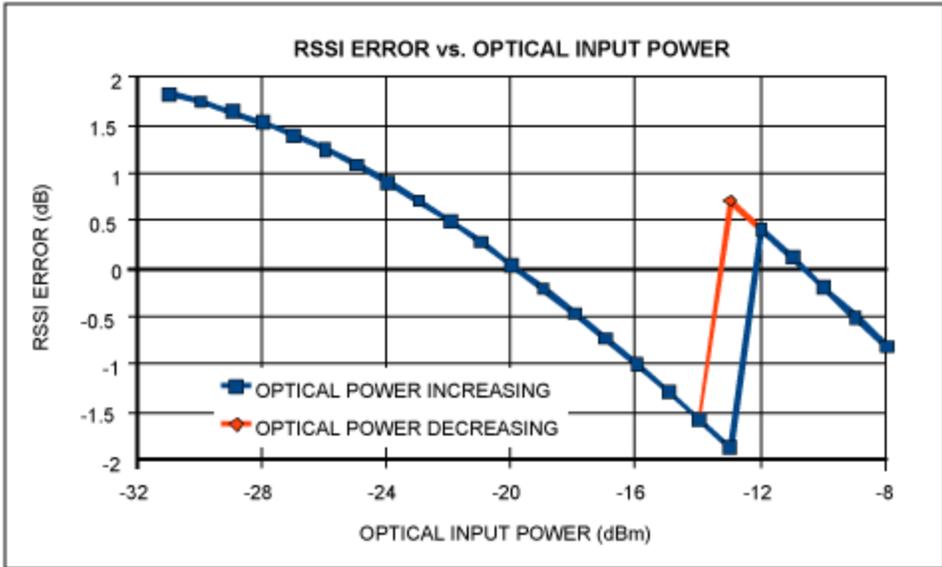


Figure 4. RSSI error in a typical APD monitor application.

Related Parts

DS1864	SFP Laser Controller and Diagnostic IC	Free Samples
MAX4007	High-Accuracy, 76V, High-Side Current Monitors in SOT23	Free Samples

More Information

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